

Finite temperature inelastic mean free path and quasiparticle lifetime in graphene

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We adopt the *GW* and random phase approximations to study finite temperature effects on the inelastic mean free path and quasiparticle lifetime by directly calculating the imaginary part of the finite temperature self-energy induced by electron-electron interaction in extrinsic and intrinsic graphene. In particular, we provide the density-dependent leading order temperature correction to the inelastic scattering rate for both single-layer and double-layer graphene systems. We find that the inelastic mean free path is strongly influenced by finite-temperature effects. We present the similarity and the difference between graphene with linear chiral band dispersion and conventional two-dimensional electron systems with parabolic band dispersion. We also compare the calculated finite temperature inelastic scattering length with the elastic scattering length due to Coulomb disorder and comment on the prospects for quantum interference effects showing up in low-density graphene transport. We also carry out inelastic scattering calculation for electron-phonon interaction, which by itself gives rather long carrier mean free paths and lifetimes since the deformation potential coupling is weak in graphene, and therefore electron-phonon interaction contributes significantly to the inelastic scattering only at relatively high temperatures.

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I. INTRODUCTION

Ever since the pioneering work by Novoselov and Geim,¹ graphene has attracted attention because of its potential application in future nanotechnology. Its chiral 2D linear dispersion leads to novel properties, distinguishing it from conventional parabolic band semiconductors. Electron-electron (e-e) interaction in graphene is of great interest, both experimentally²⁻⁵ and theoretically,⁶⁻¹¹ because it plays an important role in determining the electronic properties of graphene. The reduced dimensionality dramatically enhances the e-e interaction effects,¹² while chirality and linear dispersion have subtle qualitative and quantitative effects distinguishing graphene from the usual nonchiral parabolic semiconductor-based 2D systems.

Experimentally, the inelastic mean free path of graphene due to e-e interaction, denoted as l throughout this paper, is an essential parameter relevant for possible ultrafast device applications because this length defines the distance over which the carriers move without any energy loss.¹³ In addition, several experimental groups have investigated the temperature and gate-voltage dependencies of phase coherence length in graphene,¹⁴⁻¹⁶ which is directly determined by l , although may not always be identical to it. Thus l plays an important role in determining the quantum interference induced localization phenomenon. The electro-electron interaction induced inelastic scattering is a dominant factor in determining the weak localization effects at low temperatures¹⁴ since the phase coherence length mainly originates from Coulomb interaction among electrons. In particular, the inelastic mean free path or more specifically whether it is longer or shorter than the elastic transport mean free path is an important ingredient in understanding the origin of the recently observed metal-insulator transition in high-purity graphene devices.¹⁷⁻¹⁹

Theoretically, the inelastic quasiparticle lifetime of extrinsic or doped graphene at zero temperature has been considered in the literature.^{20,21} (In intrinsic undoped graphene, the inelas-

tic quasiparticle lifetime due to e-e interaction vanishes at the Dirac point, indicating the Dirac point to be a non-Fermi-liquid unstable point,⁶ but this is not a problem at any finite carrier density, which is the case we primarily study in this paper.) In doped extrinsic graphene, it has been found that the chiral linear dispersion of graphene results in qualitative differences in the energy dependence of inelastic quasiparticle scattering rates compared with conventional parabolic two-dimensional electron systems (2DES). Recently, Schütt *et al.* have analyzed the inelastic scattering rate induced by Coulomb interaction for intrinsic, i.e., undoped graphene.⁹ They have shown that finite temperature strongly affects the inelastic quasiparticle lifetime at the Dirac point. The inelastic scattering rate corresponds to the so-called on-shell imaginary part of self-energy $\text{Im}\Sigma^R(\mathbf{k}, \xi_{\mathbf{k}})$, \mathbf{k} being the momentum and $\xi_{\mathbf{k}}$ the quasiparticle energy measured from the chemical potential μ . So far, neither the inelastic mean free path nor the imaginary part of the self-energy of extrinsic graphene at finite temperature has been explicitly calculated. In addition, the effect of finite temperature on the off-shell imaginary part of the self-energy of intrinsic graphene has not yet been studied.

In this paper, we theoretically study the inelastic mean free path l and the imaginary part of the retarded self-energy $\text{Im}\Sigma^R(\mathbf{k}, \omega)$ in graphene within the leading order many-body perturbative *GW* approximation. The *GW* approximation involves the leading-order theory in the dynamically screened Coulomb interaction, which includes all the ring diagrams in the electron self-energy. We generalize the previous *GW* work²¹⁻²³ in the literature (carried out at $T = 0$) to finite temperatures, for both extrinsic and intrinsic graphene. We find that the finite temperature results for l and $\text{Im}\Sigma^R(\mathbf{k}, \omega)$ are very different from the zero-temperature ones due to a dramatic change in the dynamic dielectric function with increasing temperature. We also provide an analytical expression for the on-shell imaginary part of the self-energy for a double-layer graphene system, which is relevant for a recent experiment.¹⁷

We also calculate the imaginary part of the electron self-energy due to electron-phonon (e-p) interaction in graphene through the deformation potential coupling, and provide results for the corresponding inelastic mean free path as a function of temperature. In general, phonon effects are rather small in graphene because the deformation potential coupling is very weak in graphene. Thus, except at very high temperatures, phonon effects are negligible in the determination of the inelastic mean free path and quasiparticle lifetime.

The rest of this paper is organized as follows. In Sec. II, we introduce the theoretical formalism for treating inelastic e-e scattering at finite temperatures in both monolayer and double-layer graphene systems. We also obtain analytical expressions for the imaginary part of the retarded self-energy in the low-energy and low-temperature limit. In Sec. III, we provide numerical calculations of the imaginary part of the self-energy (which is the inverse of the quasiparticle lifetime) and the associated inelastic mean free path as a function of carrier energy and temperature. We also compare the inelastic mean free path with the disorder induced elastic mean free path. In Sec. IV, we provide the e-p interaction results separately, giving both the basic theory briefly and the numerical results. In Sec. V, we discuss and summarize the main results of this paper.

II. THEORETICAL FORMALISM

In this section, we provide the theoretical formalism for evaluating the finite temperature imaginary part of the retarded self-energy due to e-e interaction in graphene. We also obtain the asymptotic behavior of the imaginary part of the self-energy in the low-energy and low-temperature limit.

A. Imaginary part of self-energy for extrinsic doped graphene

The imaginary part of the retarded self-energy of monolayer graphene within GW approximation can be expressed as^{6,13}

$$\text{Im}\Sigma_s^R(k, \omega) = -\frac{1}{2} \sum_{\mathbf{q}, s'=\pm} V_q [n_B(\xi_{\mathbf{k}+\mathbf{q}, s'} - \omega) + n_F(\xi_{\mathbf{k}+\mathbf{q}, s'})] \times (1 + ss' \cos \theta) \text{Im} \left[\frac{1}{\epsilon(q, \xi_{\mathbf{k}+\mathbf{q}, s'} - \omega)} \right], \quad (1)$$

where functions n_F and n_B denote the Fermi and Bose distribution functions, respectively. $V_q = 2\pi e^2/(\kappa q)$ is the Coulomb interaction in momentum space with average background dielectric constant κ . $s, s' = \pm 1$ are band indices. $\xi_{\mathbf{k}+\mathbf{q}, s} = s\varepsilon_{\mathbf{k}+\mathbf{q}} - \mu$ ($\varepsilon_{\mathbf{k}} = \hbar v_F |\mathbf{k}|$) with graphene Fermi velocity $v_F = 10^6 \text{ m s}^{-1}$) is the carrier energy relative to the finite temperature, noninteracting chemical potential μ , determined by the conservation of the total electron density. $\epsilon(q, \omega) = 1 + V_q \Pi(q, \omega)$ is the finite temperature dynamic dielectric function within random-phase approximation (RPA),²⁴⁻²⁶ and $\Pi(q, \omega)$ is the irreducible polarizability. Note that both single-particle excitations [$\text{Im}(\epsilon) \neq 0$] and plasmon excitations [$\text{Re}(\epsilon) = 0$ and $|\text{Im}(\epsilon)| = 0^+$] contribute to $\text{Im}\Sigma_s^R(k, \omega)$. We use $\hbar = 1$ throughout.

The inverse quasiparticle lifetime or the quasiparticle scattering rate $1/\tau = \Gamma_s(\mathbf{k})$ is directly related to the imaginary

part of the on-shell self-energy, i.e.,

$$\frac{1}{\tau} = \Gamma_s(\mathbf{k}) = 2\text{Im}\Sigma_s^R(\mathbf{k}, \xi_{\mathbf{k}, s}). \quad (2)$$

The inelastic mean free path l due to e-e interaction is then given by

$$l = v_F \tau, \quad (3)$$

where v_F is the noninteracting Fermi velocity.²¹ The central quantity in our calculation is the imaginary part of the self-energy, which determines the quasiparticle lifetime. The inelastic length is a derived quantity arising from the quasiparticle lifetime, not calculated directly by the theory. For consistency in staying within the leading order in dynamically screened Coulomb interaction,^{22,23} the velocity should not have any interaction dependence and, thus, should be the bare Fermi velocity. Multiplying the quasiparticle lifetime by the renormalized velocity will mix different orders in the perturbation theory.^{21,27,28}

1. Zero-temperature analytical results $T = 0$

We first give the analytical formula for $\text{Im}\Sigma_+^R(k, \xi_k)$ at zero temperature and for $\varepsilon_F \gg \xi_k$. This has already been given in Ref. 6, and we just provide the results below for completeness and comparison.

The quasiparticle scattering rate can be obtained through the imaginary part of the self-energy within the on-shell approximation $\omega = \xi_{\mathbf{k}, s}$:

$$\text{Im}\Sigma_+^R(k, \xi_k) = \frac{1}{2} \sum_{s'=\pm} \sum_{\mathbf{q}} V_q [\vartheta(\varepsilon_k - s'\varepsilon_{\mathbf{k}+\mathbf{q}}) - \vartheta(-\xi_{\mathbf{k}+\mathbf{q}, s'})] \times (1 + s' \cos \theta) \text{Im} \left[\frac{1}{\epsilon(q, s'\varepsilon_{\mathbf{k}+\mathbf{q}} - \varepsilon_k + i0^+)} \right], \quad (4)$$

where $\vartheta(x)$ is the Heaviside unit step function.

From Eq. (4), it is straightforward to see that the interband scattering from the valence band $s' = -1$ vanishes at zero temperature. In addition, the plasmon emission process also vanishes in calculating the on-shell imaginary part of the self-energy because the plasmon frequency requires $\omega_{\text{pl}}(q) > \hbar v_F q$ for extrinsic graphene at zero temperature²⁴ but $|\varepsilon_{\mathbf{k}+\mathbf{q}} - \varepsilon_{\mathbf{k}}| < \hbar v_F q$ in the dynamic dielectric function. Thus Eq. (4) reduces to

$$\text{Im}\Sigma_+^R(k, \xi_k) = \frac{e^2}{4\pi\kappa} \int_0^{2\pi} d\theta (1 + \cos \theta) \int_{k_F}^k dk' k' \times \frac{\text{Im}[1/\epsilon(|\mathbf{k} - \mathbf{k}'|, \varepsilon_{k'} - \varepsilon_k + i0^+)]}{\sqrt{k^2 + k'^2 - 2kk' \cos \theta}}. \quad (5)$$

In the long-wavelength $x = q/2k_F \ll 1$ limit, we can obtain the analytical expression for Eq. (4). In this limit, the dominant contribution to $\text{Im}(1/\epsilon)$ comes from low energies $u = \omega/v_F q \ll 1$, where the irreducible polarizability in the leading order is given by²⁴

$$\Pi(q, \omega) \simeq D_0 \left(1 + i \frac{\omega}{v_F q} \right), \quad (6)$$

where $D_0 = \frac{2k_F}{\pi\hbar v_F}$ is the density of states at Fermi energy. Then, the asymptotic behavior of the imaginary part of the dynamic dielectric function can be written as

$$\text{Im} \frac{1}{\epsilon(q, \epsilon_{\mathbf{k}+\mathbf{q}} - \epsilon_k + i0^+)} \simeq -\frac{k' - k}{q_{\text{TF}}}, \quad (7)$$

where $k' = |\mathbf{k} + \mathbf{q}|$ and $q_{\text{TF}} = \frac{4k_F e^2}{\hbar v_F \kappa}$ denotes the Thomas-Fermi screening wave vector in graphene. To obtain Eq. (7), we have used the fact that the integrand in Eq. (5) has sharp peaks near forward scattering momentum transfer, i.e., $q = 0$. The asymptotic expansion of the imaginary part of the self-energy in Eq. (5) can then be obtained by integrating out the angular part and expanding in the small momentum transfer $k - k' \ll k_F$:

$$\text{Im} \Sigma_{k+}^R \simeq -\frac{\xi_k^2}{8\pi \epsilon_F} \left[\ln \left(\frac{\xi_k}{8\epsilon_F} \right) + \frac{1}{2} \right]. \quad (8)$$

The leading order energy correction to the on-shell imaginary part of the self-energy is $\xi_k^2 \ln \xi_k$, similar to that obtained for conventional two-dimensional electron systems (2DES).²⁹ The subleading term in Eq. (8) has opposite sign to that in 2DES because of the chiral nature of graphene and the absence of interband contribution from valence band ($s' = -1$) at zero temperature.

2. Finite temperature analytical results $T > 0$

To maintain analytic tractability for $\text{Im} \Sigma_{k+}^R$ at finite temperature, we consider only low temperatures and small ξ_k , i.e., $\epsilon_F \gg k_B T \gg \xi_k$. In this limit, both the interband scattering and the temperature dependence of $\text{Im}(1/\epsilon)$, being exponentially suppressed at low temperatures, can be ignored. Applying the same technique as in the $T = 0$ case, the finite temperature on-shell imaginary part of the self-energy can be approximated as

$$\text{Im} \Sigma_{k+}^R = \frac{e^2}{4\pi \kappa} \int_0^{2\pi} d\theta (1 + \cos \theta) \int_0^\infty dk' k' [n_B(\epsilon_{k'} - \epsilon_k) + n_F(\epsilon_k)] \frac{\text{Im}[1/\epsilon(|\mathbf{k} - \mathbf{k}'|, \epsilon_{k'} - \epsilon_k + i0^+)]}{\sqrt{k^2 + k'^2 - 2kk' \cos \theta}}. \quad (9)$$

The imaginary part of the inverse dielectric function can still be approximated as in Eq. (7). After integrating out the angular part and expanding in the limit $\xi_k \ll \epsilon_F$, the momentum integration is very straightforward, and we obtain an asymptotic formula for Eq. (9) in the limit $\epsilon_F \gg k_B T \gg \xi_k$:

$$\text{Im} \Sigma_{k+}^R \simeq -\frac{\pi(k_B T)^2}{8\epsilon_F} \left[\ln \left(\frac{k_B T}{8\epsilon_F} \right) + 1.08387 \right]. \quad (10)$$

Thus the leading order temperature correction to the on-shell $\text{Im} \Sigma_{k+}^R$ goes as $t^2 \ln t$ with $t = T/T_F$ (T_F being the Fermi temperature).

B. Imaginary part of self-energy for double-layer graphene

In this section, we provide analytical results for $\text{Im} \Sigma_{k+}^R$ of a double-layer graphene system consisting of “studied” and “control” layers of graphene separated by an insulating layer,¹⁷ which has recently been studied experimentally. These two layers of graphene are electronically isolated but the screening effect of the control layer must be considered. We will only

focus on the doped double-layer case, where Fermi levels of both layers are above the Dirac point.

The imaginary part of the self-energy of the “studied” layer for a double-layer graphene, in the presence of screening by carriers both in the control layer and the studied layer itself, can be written as^{30,31}

$$\text{Im} \Sigma_s^R(k, \omega) = \frac{1}{2} \sum_{s'=\pm, \mathbf{q}} [n_B(\xi_{\mathbf{k}+\mathbf{q}, s'} - \omega) + n_F(\xi_{\mathbf{k}+\mathbf{q}, s'})] V(q) \times (1 + ss' \cos \theta) \text{Im} \left[\frac{1}{\epsilon^{\text{scr}}(q, \xi_{\mathbf{k}+\mathbf{q}, s'} - \omega)} \right]. \quad (11)$$

Here, $\epsilon^{\text{scr}}(q, \xi_{\mathbf{k}+\mathbf{q}, s'} - \omega)$ is the RPA dynamic dielectric function for the double-layer system, which incorporates screening effects from a nearby “control” graphene layer in addition to the usual screening by the studied layer electrons themselves:^{30–32}

$$\frac{1}{\epsilon^{\text{scr}}(q, \omega)} = \frac{1 + V(q)\Pi_{22}(1 - e^{-2qd})}{1 + V(q)(\Pi_{11} + \Pi_{22}) + \Pi_{11}\Pi_{22}V(q)^2(1 - e^{-2qd})}, \quad (12)$$

where Π_{11} and Π_{22} are polarization operators of the studied and the control layer, respectively. d is the separation between the two layers. Note that Eq. (12) reduces to the dynamic dielectric function of monolayer graphene in the large d limit as it should because the two layers become decoupled in the large d limit.

1. Zero-temperature analytical results $T = 0$

In this section, we derive the analytical formula for the imaginary part of the double-layer self-energy at zero temperature in the limit $\epsilon_F \gg \xi_k$. This is very close to what we derived in the previous section for monolayer graphene but with different prefactors coming from the additional screening effects of the second nearby layer.

At zero temperature, the interband scattering from the valence band $s' = -1$ vanishes in Eq. (11), and the on-shell expression reduces to

$$\text{Im} \Sigma_{k+}^R = \frac{e^2}{4\pi \kappa} \int_0^{2\pi} d\theta (1 + \cos \theta) \int_{k_F}^k dk' k' \times \frac{\text{Im}[1/\epsilon^{\text{scr}}(|\mathbf{k} - \mathbf{k}'|, \epsilon_{k'} - \epsilon_k + i0^+)]}{\sqrt{k^2 + k'^2 - 2kk' \cos \theta}}. \quad (13)$$

In the long-wavelength $x = q/2k_{F(1,2)} \ll 1$ and low-energy $u = \omega/v_F q \ll 1$ limit, it is possible to perform an analytical evaluation of Eq. (13). In this case, the irreducible polarizability of graphene is given in the leading order by²⁴

$$\Pi_{11}(q, \omega) \simeq D_{011} \left(1 + i \frac{\omega}{v_F q} \right), \quad (14)$$

$$\Pi_{22}(q, \omega) \simeq D_{022} \left(1 + i \frac{\omega}{v_F q} \right), \quad (15)$$

where $D_{011} = \frac{2k_{F1}}{\pi\hbar v_F}$ and $D_{022} = \frac{2k_{F2}}{\pi\hbar v_F}$ correspond to the density of states at Fermi energy of the studied and the control layer, respectively.

Then, the imaginary part of the screened dielectric function is approximated as

$$\begin{aligned} \text{Im} \frac{1}{\epsilon^{\text{scr}}(q, \epsilon_{\mathbf{k}+\mathbf{q}} - \epsilon_k + i0^+)} \\ \simeq -(k' - k) \\ \times \frac{q_{TF1} + q_{TF2} + 4q_{TF1}q_{TF2}d + 4q_{TF1}(q_{TF2}d)^2}{(q_{TF1} + q_{TF2} + 2q_{TF1}q_{TF2}d)^2}, \end{aligned} \quad (16)$$

where $q_{TF1} = \frac{4k_{F1}e^2}{\hbar v_{Fk}}$ and $q_{TF2} = \frac{4k_{F2}e^2}{\hbar v_{Fk}}$ are the Thomas-Fermi wave vectors of the studied and the control graphene layer. In deriving Eq. (16), we have used the long-wavelength limit $|\mathbf{k} - \mathbf{k}'|/2k_F \ll 1$, which also indicates that $|\mathbf{k} - \mathbf{k}'|d \ll 1$ for $d \sim O(1 \text{ nm})$ and $\frac{(k' - k)}{|\mathbf{k} - \mathbf{k}'|} \ll 1$. From Eq. (16), we see that the difference in the analytical expressions for $\text{Im}\Sigma_{\pm}^R$ between monolayer and double-layer graphene comes from the second line of Eq. (16).

Using the approximation (16) in Eq. (13), we obtain the final analytical formula:

$$\begin{aligned} \text{Im}\Sigma_{k+}^R \simeq -\frac{\xi_k^2}{8\pi\epsilon_{F1}} \left[\ln\left(\frac{\xi_k}{8\epsilon_{F1}}\right) + \frac{1}{2} \right] \\ \times \frac{1 + \sqrt{n_2}/\sqrt{n_1} + 16r_s d \sqrt{\pi n_2} + 64r_s^2 d^2 \pi n_2}{(1 + \sqrt{n_2}/\sqrt{n_1} + 8r_s d \sqrt{\pi n_2})^2}, \end{aligned} \quad (17)$$

where n_1, n_2 are the carrier densities of the studied and the control layers, respectively, $r_s = e^2/(\hbar v_{Fk})$ is the graphene fine structure constant defining the e-e interaction strength, and ϵ_{F1} is the Fermi energy of the studied layer. It is clear that Eq. (17), as expected, reduces to the monolayer graphene result as given in Eq. (8) for two extremes: $n_2 = 0$ and $d \rightarrow \infty$.

2. Finite temperature analytical results $T > 0$

Next, we provide the analytical expression for the imaginary part of the self-energy of a double-layer graphene in the low- T and small- ξ limit, i.e., $\epsilon_{F(1,2)} \gg k_B T \gg \xi_k$ as before.

In the low-temperature limit, we neglect both the interband scattering and the temperature-dependent imaginary part of the dielectric function, which are exponentially suppressed. Then, the asymptotic expansion of Eq. (11) is given by

$$\begin{aligned} \text{Im}\Sigma_{k+}^R \simeq -\frac{\pi(k_B T)^2}{8\epsilon_{F1}} \left[\ln\left(\frac{k_B T}{8\epsilon_{F1}}\right) + 1.08387 \right] \\ \times \frac{1 + \sqrt{n_2}/\sqrt{n_1} + 16r_s d \sqrt{\pi n_2} + 64r_s^2 d^2 \pi n_2}{(1 + \sqrt{n_2}/\sqrt{n_1} + 8r_s d \sqrt{\pi n_2})^2}. \end{aligned} \quad (18)$$

C. Imaginary part of self-energy for intrinsic graphene

The imaginary part of the self-energy for undoped or intrinsic monolayer graphene can be obtained by setting $\mu \equiv 0$ in Eq. (1), in which case the chemical potential is always independent of temperature. At zero temperature, the analytical form of the irreducible polarizability for intrinsic

graphene²⁴ is

$$\Pi = \frac{q^2}{4} \left[\frac{\theta(v_F q - \omega)}{\sqrt{(v_F^2 q^2 - \omega^2)}} + i \frac{\theta(\omega - v_F q)}{\sqrt{(\omega^2 - v_F^2 q^2)}} \right]. \quad (19)$$

Then, the imaginary part of the self-energy within the on-shell approximation $\epsilon = \epsilon_k$ at zero temperature reduces to the product of two ϑ functions:⁶

$$\text{Im}\Sigma_{\pm}^R(k, \epsilon_k) \sim \Sigma_{\mathbf{q}} \vartheta(|\epsilon_{\mathbf{k}+\mathbf{q}} - \epsilon_k| - \epsilon_q) \vartheta(\epsilon_k - \epsilon_{\mathbf{k}+\mathbf{q}}). \quad (20)$$

The first ϑ function is due to the imaginary part of the dynamic dielectric function, while the second one comes from the sum of the Fermi and Bose distribution functions at $T = 0$. It is easy to see from the above equation that $\text{Im}\Sigma_{\pm}^R(k, \epsilon_k)$ vanishes because of phase space restrictions imposed by the ϑ function. On the other hand, we can evaluate the zero temperature imaginary part of the self-energy at zero momentum $k = 0$ and finite energy ω by using the polarizability given in Eq. (19).

Then the imaginary part of the self-energy at $k \equiv 0$ is given by

$$\text{Im}\Sigma_{\pm}^R(k = 0, \omega) = \omega f(r_s) \quad (21)$$

with

$$\begin{aligned} f(x) = \frac{2}{\pi^2 x} \left[\pi(1-x) + \frac{2 - (\pi x/2)^2}{\sqrt{(\pi x)^2 - 4}} \right. \\ \left. \times \ln \frac{\pi x - \sqrt{(\pi x)^2 - 4}}{\pi x + \sqrt{(\pi x)^2 - 4}} \right], \end{aligned} \quad (22)$$

which was already obtained in Ref. 6. Note that for the general case (\mathbf{k}, ω) , it is almost impossible to get an analytical formula for the imaginary part of the self-energy due to the complicated angular integration. However, we know that $\text{Im}\Sigma_{\pm}^R(\mathbf{k}, \omega) \equiv 0$ for $\omega < \hbar v_{Fk}$ at zero temperature because of the combination of the two ϑ functions mentioned above.

Next, we mention that the analytical formula for the finite temperature imaginary part of the self-energy for the intrinsic undoped graphene is quite tricky, necessitating a very careful analysis of the finite temperature dynamic dielectric function. Since undoped graphene is not the focus of our current work, we refer the reader to Ref. 9, where the on-shell imaginary part of the self-energy in intrinsic graphene has been recently studied. Note that the finite temperature imaginary part of the on-shell self-energy is proportional to the temperature T , as can be shown by dimensional counting and can also be seen from the numerical results shown in Sec. III. In addition, we find that the leading order temperature correction to the imaginary part of the self-energy for two cases: $k = 0$ and $k_B T \ll |\omega - \epsilon_k|$, are exponentially suppressed. Since the self-energy for the undoped case has already been studied analytically in some details in Ref. 9, we do not provide any further discussion of this issue in this paper. We also add that from the experimental perspective, pure intrinsic graphene is uninteresting since it is unstable to any (for example, disorder-induced) density fluctuations, which would locally dope the Dirac point, and thus, all experimentally studied graphene samples are likely to be extrinsic doped graphene.

III. NUMERICAL RESULTS

In this section, we provide our numerical results for both inelastic mean free path and the imaginary part of the self-energy (which is essentially the inelastic scattering rate or the inverse of the quasiparticle lifetime) for both extrinsic and intrinsic graphene. If not specified, the effective background dielectric constant used in our calculation is $\kappa = 5$, i.e., $r_s = 0.44$, corresponding to monolayer graphene sandwiched between two boron-nitride layers.¹⁷ We compare our numerical results with the asymptotic analytical results derived in Sec. II. We also calculate the ratio between the inelastic mean free path and the elastic mean free path induced by long-range Coulomb disorder as a function of temperature in order to assess the importance of possible quantum interference effects in highly resistive graphene samples at low temperatures.

A. Inelastic mean free path and imaginary part of self-energy for extrinsic graphene

In Fig. 1, we compare our calculated analytical results of the on-shell imaginary part of the self-energy with the numerical results, which show good agreement with each other. The ratio λ is $\text{Im}\Sigma_+^R(\mathbf{k}_F, \xi_{\mathbf{k}_F})$, calculated numerically at finite temperature, divided by its value given by Eq. (10), while the ratio σ is $\text{Im}\Sigma_+^R(\mathbf{k}, \xi_{\mathbf{k}})$, calculated numerically at zero temperature, divided by its value given by Eq. (8). Both ratios λ and σ are closer to unity for smaller background dielectric constant κ . This is because the approximation used in Eq. (7) is more accurate for a larger value of qT_F . In Fig. 1(a), the nonmonotonic behavior in λ for $\kappa = 1$ is due to its denominator, i.e., Eq. (10), which is a nonmonotonic function of T/T_F . For $\kappa = 5$, the nonmonotonic behavior in λ will show up at higher T/T_F . Similarly, the nonmonotonic behavior of σ will show up at larger values of $\xi_{\mathbf{k}}/E_F$. Note that both ratios λ and σ are independent of Fermi-energy E_F for a fixed fine structure constant r_s within the GW approximation. We want to mention that both ratios in graphene have opposite trends compared with 2DES in the sense that in the latter system λ and σ are both larger than unity as they approach unity

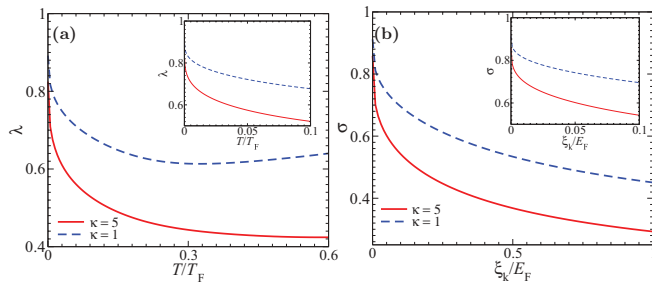


FIG. 1. (Color online) (a) Calculated ratio λ , which is the numerical result of $\text{Im}\Sigma_+^R(\mathbf{k}_F, \xi_{\mathbf{k}_F})$ divided by the analytical asymptotic formula $-\frac{\pi(k_B T)^2}{8\pi\epsilon_F} [\ln(\frac{k_B T}{8\epsilon_F}) + 1.08387]$ [given in Eq. (10)], as a function of T/T_F . The inset presents λ in the low-temperature regime. (b) Calculated ratio σ , the numerical result of $\text{Im}\Sigma_+^R(\mathbf{k}, \xi_{\mathbf{k}})$ divided by $-\frac{\xi_{\mathbf{k}}^2}{8\pi\epsilon_F} [\ln(\frac{\xi_{\mathbf{k}}}{8\epsilon_F}) + \frac{1}{2}]$ [given in Eq. (8)] as a function of $\xi_{\mathbf{k}}/E_F$ at $T = 0$. The inset presents σ in the low-energy regime. The solid and dashed lines correspond to $\kappa = 5$ ($r_s = 0.44$) and $\kappa = 1$ ($r_s = 2.2$), respectively.

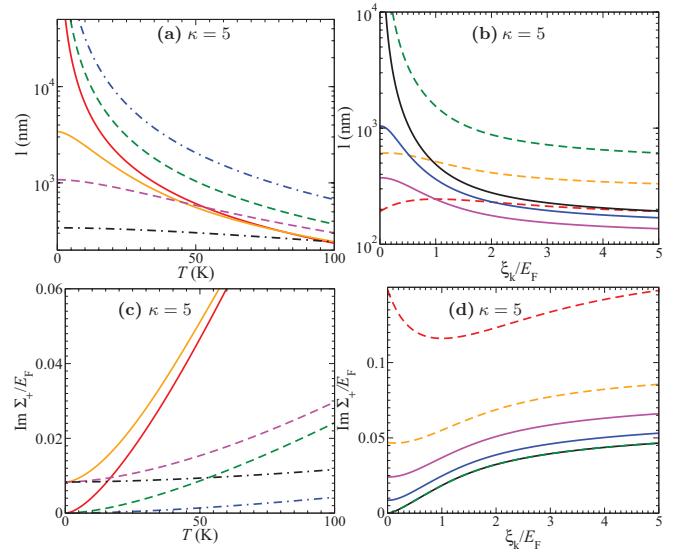


FIG. 2. (Color online) Calculated inelastic scattering length l and the associated on-shell imaginary part of the self-energy $\text{Im}\Sigma_+^R(k, \xi_{\mathbf{k}})/E_F$ for extrinsic graphene ($\epsilon_F > 0$) with dielectric constant $\kappa = 5$ ($r_s = 0.44$). (a) l as a function of temperature T . The solid, dashed, and dot-dashed lines are for carrier density $n = 10^{10}$, 10^{11} , and 10^{12} cm^{-2} , respectively. The upper three lines are for $\xi_{\mathbf{k}} = \xi_{\mathbf{k}_F}$, while the lower three lines are for $\xi_{\mathbf{k}} = 0.5\epsilon_F$. (b) l as a function of $\xi_{\mathbf{k}}/E_F$ for different temperatures. The solid and dashed lines are for carrier density $n = 10^{11}$ and 10^{10} cm^{-2} , respectively. For the same carrier density, the lines from top to bottom correspond to $T = 0, 50$, and 100 K. (c) and (d) Associated $\text{Im}\Sigma_+^R(k, \xi_{\mathbf{k}})/E_F$ corresponding to (a) and (b), respectively.

asymptotically,^{22,23} whereas in graphene the ratios always lie below unity. We mention that it is quite interesting to note that the asymptotic expressions, although they are derived for energy or temperature being much smaller than E_F or T_F , appear to be valid quantitatively within a factor of two well outside the asymptotic regime, i.e., even when $T \sim T_F$.

Figure 2 shows our numerical results for the energy and temperature dependence of the inelastic mean free path l and the associated on-shell imaginary part of the self-energy. In Fig. 2(a), we present the inelastic mean free path l as a function of temperature for two different carrier energy values. We can see that l is a monotonically decreasing function of temperature. In particular, the injected electron can only decay via intraband processes at zero temperature as discussed in Sec. II A1. In addition, the decay via plasmon emission is inhibited at zero temperature due to phase-space restrictions.²¹ On the other hand, at finite temperatures, the injected electron can decay via both interband and intraband excitations and the region of single-particle excitations also increases due to thermal smearing effects. Figure 2(b) shows the energy dependence of l for different temperatures and carrier densities. At low temperatures, the mean free path of hot electrons ($\epsilon_{\mathbf{k}} > E_F$) is shorter than that of the quasiparticle in the vicinity of the Fermi energy. However, very interestingly, the energy dependence of l becomes nonmonotonic at higher temperatures [see the lowest dashed line in Fig. 2(b)]. This arises from the competition between damping through valence and conduction bands, which have opposite trends as a function

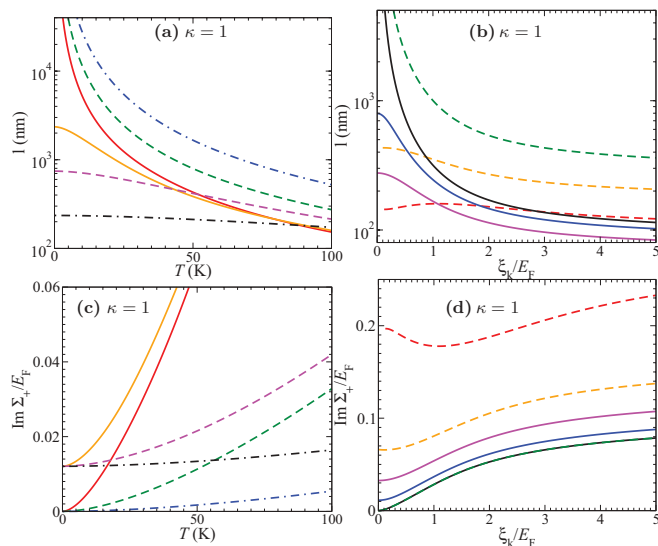


FIG. 3. (Color online) Calculated inelastic scattering length l and the associated on-shell imaginary part of the self-energy $\text{Im}\Sigma_+^R(k, \xi_k)/E_F$ for extrinsic graphene ($\epsilon_F > 0$) with dielectric constant $\kappa = 1$ ($r_s = 2.2$). (a) l as a function of temperature T . The solid, dashed, and dot-dashed lines are for carrier density $n = 10^{10}$, 10^{11} , and 10^{12} cm^{-2} , respectively. The upper three lines are for $\xi_k = \xi_{k_F}$, while the lower three lines are for $\xi_k = 0.5\epsilon_F$. (b) l as a function of ξ_k/E_F for different temperatures. The solid and dashed lines are for carrier density $n = 10^{11}$ and 10^{10} cm^{-2} , respectively. For the same carrier density, the lines from top to bottom correspond to $T = 0, 50$, and 100 K. (c) and (d) Associated $\text{Im}\Sigma_+^R(k, \xi_k)/E_F$ corresponding to (a) and (b), respectively.

of carrier energy. To be more specific, the scattering rate from the valence band contribution ($s' = -1$) is a monotonically decreasing function of ξ_k/E_F , while the contribution from the conduction band ($s' = 1$) is a monotonically increasing function of ξ_k/E_F . Figures 2(c) and 2(d) provide the on-shell $\text{Im}\Sigma_+^R(\mathbf{k}, \xi_k)$. We point out that $\text{Im}\Sigma_+^R(\mathbf{k}, \xi_k)/E_F$ for the two carrier densities at zero temperature in Fig. 2(d) are essentially the same because the rescaled $\text{Im}\Sigma_+^R(\mathbf{k}/k_F, \xi_k/E_F)/E_F$ is universal at $T = 0$. Notice that in our theoretical GW formalism, we exclude multiparticle excitations, which have a relatively small effect on l in graphene²¹ because of the small values of r_s implying weak e-e interaction strength.

For the purpose of comparison, in Fig. 3, we show results of l and $\text{Im}\Sigma_+$ for suspended graphene with the background dielectric constant $\kappa = 1$ ($r_s = 2.2$). From Figs. 2 and 3, we can see that the results of the mean free path l for different values of r_s are qualitatively very similar. The inelastic scattering length l is larger for smaller r_s because of the weaker e-e interaction. At low temperatures ($T < 10$ K), our calculated quasiparticle mean free path for $\xi_k = \xi_{k_F}$ is on the order of 5×10^3 – 10^5 nm. However, the typical mean free path measured in the experiment will saturate at low temperatures and it is about a few micrometers at liquid-helium temperature.^{15,16} This saturation is due to the sample size and this issue has been discussed by Tikhonenko *et al.*¹⁵

To capture the effects of plasmons and interband single-particle excitations, we have to consider the off-shell imaginary part of the self-energy $\text{Im}\Sigma^R(\mathbf{k}, \omega)$ ($\omega \neq \xi_{k,s}$), which is also

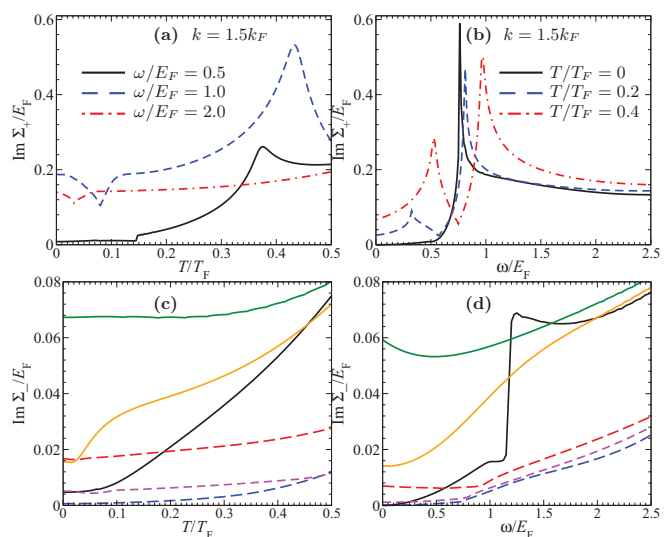


FIG. 4. (Color online) Calculated $\text{Im}\Sigma^R(k, \omega)$ for extrinsic graphene (the chemical potential $\mu > 0$) with $\kappa = 5$. (a) and (b) correspond to conduction band, while (c) and (d) correspond to valence band. In (a), the solid, dashed and dot-dashed lines correspond to $\omega/E_F = 0.5, 1.0$ and 2.0 , respectively. (b) The solid, dashed, and dot-dashed lines correspond to $T/T_F = 0, 0.2$ and 0.4 , respectively. In (c) and (d), the solid and dashed lines correspond to $k = 0$ and $k = 1.5k_F$. (c) For the same momentum, the lines from bottom to top correspond to $\omega/E_F = 0.5, 1.0$ and 2.0 , respectively. (d) For the same momentum, the lines from bottom to top correspond to $T/T_F = 0, 0.2$, and 0.4 , respectively. Note that $\text{Im}\Sigma_+^R(k = 0, \omega) = \text{Im}\Sigma_-^R(k = 0, \omega)$.

needed to explain the experimental angle-resolved photoemission spectroscopy (ARPES) data.^{7,21,33} The numerical results for $\text{Im}\Sigma^R(\mathbf{k}, \omega)$ are shown in Fig. 4. Unlike the calculation for the on-shell imaginary part of the self-energy, we can see that the off-shell imaginary part of the self-energy contains two kinds of contributions from Eq. (4). The first comes from the single-particle excitation occurring at $\text{Im}\epsilon \neq 0$. This can be further divided into intraband and interband excitations because of the gaplessness of graphene. The second contribution comes from plasmon excitations, where both $\text{Im}\epsilon$ and $\text{Re}\epsilon$ vanish. The plasmon resonance consists of a δ function at zero temperature, of which the width will be broadened as temperature increases. Figures 4(a) and 4(b) present the rescaled conduction band $\text{Im}\Sigma_+^R(\mathbf{k}, \omega)/E_F$ with $k = 1.5k_F$ as a function of rescaled temperature T/T_F and energy ω/E_F . We point out that $\text{Im}\Sigma_+^R(\mathbf{k}/k_F, \omega/E_F)/E_F$ is universal, not depending on the position of the Fermi level but only on the graphene fine structure constant r_s . The nonmonotonic temperature dependence of $\text{Im}\Sigma_+^R$ for fixed ω/E_F as shown in Fig. 4(a) comes from the competition among interband, intraband, and plasmon excitations. In the zero-temperature limit, it has been shown in Ref. 21 that the plasmon contribution dominates in the low-energy regime for $k/k_F \gtrsim 1$, and it vanishes in the higher energy regime. As the temperature goes up, the plasmon contribution is not a δ function anymore and it gets broadened by Landau damping [see Fig. 4(b)]. Also, the boundaries of both interband and intraband excitations are thermally smeared. The above two effects give rise to the appearance of a smaller bump in $\text{Im}\Sigma_+^R$

in the lower energy region at finite temperature as shown in Fig. 4(b). Figures 4(c) and 4(d) show the imaginary part of the self-energy for the valence band $\text{Im}\Sigma_-^R$. $\text{Im}\Sigma_-^R$ is generally an increasing function of temperature. In the $k = 0$ and $T = 0$ limit, only single-particle excitations contribute to $\text{Im}\Sigma_-^R(0, \omega)$ and there is no plasmon emission because it requires $q < k_F$. But the integrand in Eq. (1) has nonzero values only for $q > k_F$, being restricted by the sum of the Bose and Fermi distribution functions, i.e., $(\omega + E_F - \varepsilon_q)(E_F - \varepsilon_q) < 0$. In particular, only intraband single-particle excitations contribute for energy $\omega/E_F \lesssim 1$ and the interband single-particle excitation contribution increases sharply around $\omega/E_F \sim 1$. On the other hand, for $k = 0$ but at nonzero temperature, $\text{Im}\Sigma^R(0, \omega)$ becomes much smoother compared with the zero temperature case. In addition, $\text{Im}\Sigma^R(0, 0)$ has a finite value increasing with temperatures due to the thermally smeared boundaries of single particle excitation continua. Note that $\text{Im}\Sigma_-^R = \text{Im}\Sigma_+^R$ for $k = 0$ as seen from Eq. (1), in which case the equation has no band-index dependence.

B. Comparison between inelastic and elastic mean free paths in extrinsic graphene

In this section, we compare the inelastic mean free path l induced by e-e interaction with the elastic mean free path l_e due to charged impurity in the environment. The ratio $\zeta = l/l_e \gg 1$ is the necessary condition for quantum interference effects to be operational in experiments since interference necessarily requires the phase coherence of energy eigenstates. A detailed discussion on this issue has been given in Ref. 18, where, however, the inelastic mean free path was not calculated. In Fig. 5, we show our calculated ratio ζ as a function of temperature for different values of the potential fluctuation (i.e., puddle) parameter s . This parameter is defined as the standard deviation of the probability distribution of the disorder potential at a given point in the graphene plane. It can be tuned using screening by the second nearby graphene layer.¹⁸ A detailed calculation for the elastic mean free path

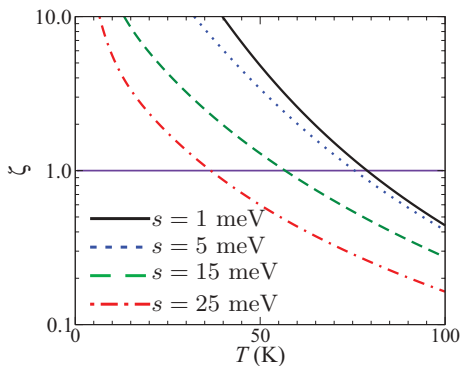


FIG. 5. (Color online) Calculated ratio $\zeta = l/l_e$, the inelastic mean free path divided by the elastic mean free path, as a function of temperature for carrier density $n = 10^9 \text{ cm}^{-2}$, $\kappa = 5$, and charged impurity density $9 \times 10^{10} \text{ cm}^{-2}$. The solid, dotted, dashed, and dot-dashed lines correspond to $s = 1.0, 5.0, 15.0,$ and 25.0 meV , respectively, indicating increasing effects of Coulomb disorder induced inhomogeneous puddles. The horizontal line indicates where (above the line) quantum interference could play a role.

l_e has been given in Ref. 34. Note that we do not take into account e-p scattering in the calculation of the mean free path here since the temperature ($T < 100 \text{ K}$) is relatively low and the inelastic mean free path can be even shorter if we include electron-phonon scattering mechanism. We defer our discussion of e-p interaction to Sec. IV of the paper.

C. Inelastic mean free path and imaginary part of self-energy for intrinsic graphene

In this section, we show our numerical results for the inelastic mean free path l and the imaginary part of the self-energy for intrinsic graphene. The behavior of inelastic e-e scattering of intrinsic graphene is quite different from that of extrinsic graphene. Intrinsic graphene is a marginal Fermi liquid.⁶ By contrast, extrinsic graphene is a well-defined and relatively weak-coupling Fermi liquid since typically $r_s < 1$ and is independent of the carrier density.

In order to compare with the results provided for extrinsic graphene, we show the finite- T inelastic scattering mean free path l for intrinsic graphene in Figs. 6(a) and 6(b) and the corresponding imaginary part of the self-energy in Figs. 6(c) and 6(d) using similar parameters as used for our extrinsic graphene results. Similar to extrinsic graphene, the inelastic mean free path of intrinsic graphene is a monotonically decreasing function of temperature. However, the leading order temperature dependence of $\text{Im}\Sigma_+^R(\mathbf{k}, \varepsilon_{\mathbf{k}})$ for intrinsic graphene is linear in T as shown in Fig. 6. At zero temperature, $\text{Im}\Sigma_+^R(\mathbf{k}, \xi_{\mathbf{k}})$ vanishes due to phase-space restrictions leading to infinite l . On the other hand, finite temperature effects give rise to a nonmonotonic energy-dependent l and $\text{Im}\Sigma_+^R(\mathbf{k}, \xi_{\mathbf{k}})$.

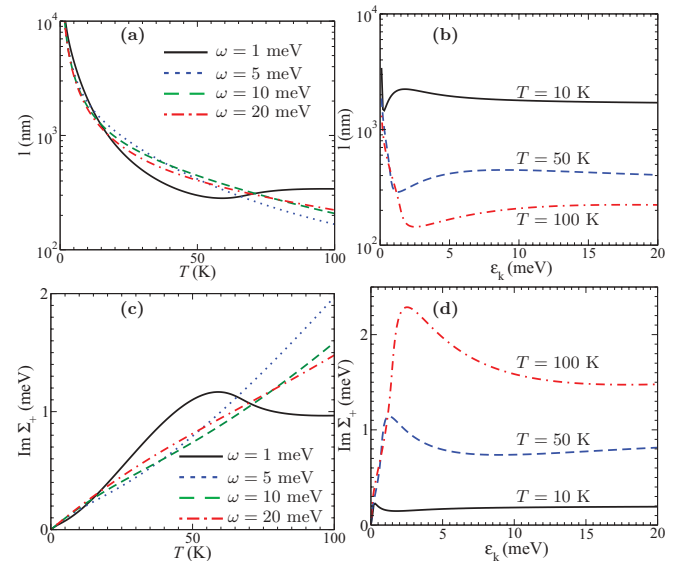


FIG. 6. (Color online) Calculated inelastic scattering length l and the associated on-shell imaginary part of the self-energy $\text{Im}\Sigma_+^R(k, \varepsilon_{\mathbf{k}})$ for intrinsic graphene ($\varepsilon_F \equiv 0$) with dielectric constant $\kappa = 5$. (a) l as a function of temperature T for different energy $\varepsilon_{\mathbf{k}}$. The solid, dotted, dashed, and dot-dashed lines are for energy $\varepsilon_{\mathbf{k}} = 1, 5, 10,$ and 20 meV . (b) l as a function of energy ω for different temperatures. The solid, dashed, and dot-dashed lines are for temperature $T = 10, 50,$ and 100 K . (c) and (d) Associated $\text{Im}\Sigma_+^R(k, \varepsilon_{\mathbf{k}})$ corresponding to (a) and (b), respectively.

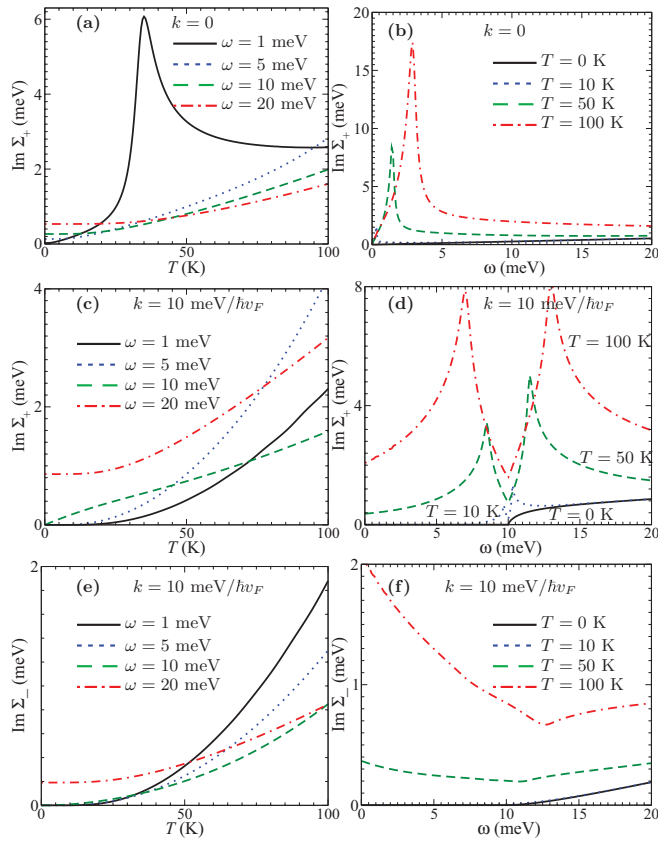


FIG. 7. (Color online) Calculated imaginary part of the self-energy $\text{Im}\Sigma^R(k, \omega)$ for intrinsic graphene (the chemical potential $\mu \equiv 0$) with $\kappa = 5$. (a) and (b) Conduction band $\text{Im}\Sigma_+^R(k=0, \omega)$ as a function of temperature T and energy ω , respectively. (c) and (d) Conduction band $\text{Im}\Sigma_+^R(k, \omega)$ with $k = 10 \text{ meV}/\hbar v_F$ as a function of temperature T and energy ω , respectively. (e) and (f) Valence band $\text{Im}\Sigma_-^R(k, \omega)$ with $k = 10 \text{ meV}/\hbar v_F$ as a function of temperature T and energy ω , respectively. The solid, dotted, dashed, and dot-dashed lines in (a), (c), and (e) are for energy $\omega = 1, 5, 10,$ and 20 meV . While the solid, dotted, dashed, and dot-dashed lines in (b), (d), and (f) are for temperature $T = 0, 10, 50,$ and 100 K . Note that $\text{Im}\Sigma_+^R(k=0, \omega) = \text{Im}\Sigma_-^R(k=0, \omega)$.

$\text{Im}\Sigma_+^R(\mathbf{k}, \varepsilon_{\mathbf{k}})$ (or the quasiparticle scattering rate) first increases linearly with $\varepsilon_{\mathbf{k}}$ and then decreases with $\varepsilon_{\mathbf{k}}$. This nonmonotonic energy-dependent feature of $\text{Im}\Sigma_+^R(\mathbf{k}, \xi_{\mathbf{k}})$ has also been found in Ref. 9, and can be explained by the peculiar property of the dynamic dielectric function of intrinsic graphene at finite temperatures.

The numerical results for the off-shell $\text{Im}\Sigma^R(k, \omega)$ for intrinsic graphene are shown in Fig. 7. Figure 7(a) presents $\text{Im}\Sigma_+^R(0, \omega)$ as a function of temperature T . Quite different from extrinsic graphene, where the plasmon peaks are broadened by Landau damping due to finite temperature effects, intrinsic graphene has no plasmon excitations at zero temperature as seen from Eq. (19). Note, however, that the plasmon modes are thermally restored at finite temperatures in intrinsic graphene. We find that there is a peak in $\text{Im}\Sigma^R(0, \omega)$ as a function of temperature, which arises from the appearance of thermal plasmon modes. In particular, the position of these peaks is approximately proportional to the energy ω because the rescaled function $\text{Im}\tilde{\Sigma}^R(\tilde{k}, \tilde{\omega})$ is universal with

respect to the rescaling, $\tilde{\Sigma}^R = \Sigma^R/(k_B T)$, $\tilde{k} = \hbar v_F k/(k_B T)$ and $\tilde{\omega} = \omega/(k_B T)$. Only the line of $\text{Im}\Sigma^R(0, \omega)$ with $\omega = 1 \text{ meV}$ in Fig. 7(a) shows a peak since the position of peaks for higher energy lie outside of the temperature regime we are interested in. Figure 7(b) shows the energy dependence of $\text{Im}\Sigma_+^R(0, \omega)$ for several values of temperature. At zero temperature, $\text{Im}\Sigma_+^R(0, \omega)$ is linearly increasing as a function of ω indicated in Eq. (21). In the lower-energy regime, $\text{Im}\Sigma_+^R(0, \omega)$ shows a peak associated with the resonance of plasmon excitations. Specifically, both the position and the height of the peak are roughly proportional to temperature T as mentioned above. The finite temperature $\text{Im}\Sigma_+^R(0, \omega)$ approaches the zero temperature $\text{Im}\Sigma_+^R(0, \omega)$ as the energy ω further increases. According to Fig. 7(c), the temperature dependence of off-shell conduction band $\text{Im}\Sigma_+^R(k, \omega)$ is exponentially suppressed, while the on-shell $\text{Im}\Sigma_+^R(k, \omega)$ is proportional to T at low temperatures. We plot the conduction band $\text{Im}\Sigma_+^R(k, \omega)$ as a function of energy in Fig. 7(d). One interesting feature is that $\text{Im}\Sigma_+^R(k, \omega)$ vanishes for $\omega < \varepsilon_{\mathbf{k}}$ and increases rapidly with ω for $\omega > \varepsilon_{\mathbf{k}}$ at zero temperature. As the temperature increases, two characteristic peaks show up in $\text{Im}\Sigma_+^R(k, \omega)$ similar to extrinsic graphene as shown in Fig. 4(b). This arises from an interplay between plasmon enhancement and thermally smeared single-particle continuum boundaries. We have found that the positions of these peaks $|\omega_{\text{pl}} - \varepsilon_{\mathbf{k}}|$ are proportional to the temperature T . We provide the valence band $\text{Im}\Sigma_-^R(k, \omega)$ as a function of temperature T and energy ω in Figs. 7(e) and 7(f), respectively. The low-temperature correction to $\text{Im}\Sigma_-^R(k, \omega)$ is exponentially suppressed for $\omega > 0$ due to the constraint imposed by the Fermi and Bose distribution functions in Eq. (1). $\text{Im}\Sigma_-^R(k, \omega)$ increases rapidly at higher temperatures, especially, for small energy ω . From Fig. 7(f), we can see that $\text{Im}\Sigma_-^R(k, \omega)$ increases slowly with ω for $\omega > \varepsilon_{\mathbf{k}}$ at low temperatures and $\text{Im}\Sigma_-^R(k, \omega)$ shows nonmonotonic dependence on ω at higher temperature. This nonmonotonicity can be understood through the competition between a decrease in valence band contribution ($s' = -1$) and an increase in conduction band contribution ($s' = 1$) with increasing energy ω .

IV. MEAN FREE PATH DUE TO ELECTRON-PHONON INTERACTION

In this section, we present results for the mean free path l_{ep} induced by e-p interaction. We analytically calculate its high- ($T \gg T_{\text{BG}}$) and low-temperature ($T \ll T_{\text{BG}}$) limits, where T_{BG} is the Bloch-Grüneisen temperature, while in the intermediate temperature regime we provide numerical results. In addition, we consider the energy and carrier density dependence of l_{ep} for different values of temperature. In this work, we consider acoustic phonons only and neglect the optical phonons because their energy in graphene is too high ($\sim 2000 \text{ K}$) for them to play any important role in the temperature range ($T \lesssim 500 \text{ K}$) of our interest.

A. Imaginary part of self-energy due to e-p interaction

The mean free path l_{ep} is directly related to the on-shell imaginary part of the self-energy, i.e., $l_{\text{ep}} = v_F/[2\text{Im}\Sigma_+^{\text{ep}}(k, \xi_{\mathbf{k}})]$, as given in Sec. II. Thus we first present

the theoretical formalism for calculating $\text{Im}\Sigma_s^{\text{ep}}(k, \omega)$. We consider the e-p interaction through the deformation potential coupling. In this case, $\text{Im}\Sigma_s^{\text{ep}}(k, \omega)$ is given by³⁵

$$\text{Im}\Sigma_s^{\text{ep}}(k, \omega) = \pi \sum_{s', v} \int \frac{d^2q}{(2\pi)^2} |M|^2 \frac{1 + ss' \cos \theta}{2} \times [n_F(\omega_q + \nu\omega) + n_B(\omega_q)] \delta(\omega + \nu\omega_q - \epsilon'), \quad (23)$$

where $|M|^2 = \frac{D^2 \hbar q}{2\rho_m v_l}$ is the e-p scattering matrix element, while D , ρ_m , and v_l are the deformation potential, the graphene mass density, and the phonon velocity, respectively. $s, s' = \pm 1$ denote the band indices, $\nu = 1$ (-1) corresponds to the absorption (emission) of an acoustic phonon with frequency $\omega_q = v_l q$. $\epsilon' = s' \hbar v_F |\mathbf{k} + \mathbf{q}| - \mu$, and θ is the angle between \mathbf{k} and $\mathbf{k} + \mathbf{q}$.

B. The asymptotic behavior of $\text{Im}\Sigma_s^{\text{ep}}(k, \xi_k)$

We start with the asymptotic behavior for the energy and temperature dependence of $\text{Im}\Sigma_s^{\text{ep}}$, calculated analytically within the quasielastic scattering approximation,^{36–38} namely, $|\mathbf{k}| \sim |\mathbf{k} + \mathbf{q}|$. This approximation is justified by the fact that the phonon velocity is much smaller than the Fermi velocity v_F in graphene.

At zero temperature, n_F becomes the Heaviside unit step function, $n_B(\omega_q) \equiv 0$, and the interband scattering vanishes. Then, the integration in Eq. (23) can be carried out in the limit $\xi_k \ll E_F$ as

$$\text{Im}\Sigma_+^{\text{ep}}(k, \xi_k) \simeq \frac{1}{8\pi} \frac{D^2 k_F^2}{\rho_m v_l v_F} \left(\frac{v_F}{v_l}\right)^2 \left(\frac{\xi_k}{E_F}\right)^2, \quad (24)$$

which shows that $\text{Im}\Sigma_+^{\text{ep}}(k, \xi_k)$ increases quadratically with increasing quasiparticle energy, in contrast to $\text{Im}\Sigma_+(k, \xi_k) \propto \xi_k^2 \ln \xi_k$ induced by e-e interaction. Equation (24) implies that $l_{\text{ep}} \propto \xi_k^{-2}$ at $T = 0$.

Next, we consider the temperature dependence of $\text{Im}\Sigma_+^{\text{ep}}(k, \xi_k)$. In the low-temperature Bloch-Grüneisen limit, $T \ll T_{\text{BG}}$, with $T_{\text{BG}} = 2k_F v_l / k_B$, where the phonon system is degenerate, we get the following asymptotic form for the on-shell $\text{Im}\Sigma_+^{\text{ep}}(k, \omega)$:

$$\text{Im}\Sigma_+^{\text{ep}}(k_F, \xi_{k_F}) \simeq \frac{\pi}{2} \frac{D^2 k_F^2}{\rho_m v_l v_F} \left(\frac{T}{T_{\text{BG}}}\right)^2. \quad (25)$$

In the Bloch-Grüneisen regime, the temperature dependence of l_{ep} is a power law with $l_{\text{ep}} \propto T^{-2}$. We also find that l_{ep} does not depend on the carrier density in the low-temperature limit.

On the other hand, in the high-temperature regime $T_F \gg T \gg T_{\text{BG}}$, where the phonon follows the nondegenerate equipartition distribution, the asymptotic formula for the on-shell $\text{Im}\Sigma_+^{\text{ep}}(k, \omega)$ is given by

$$\text{Im}\Sigma_+^{\text{ep}}(k_F, \xi_{k_F}) \simeq \frac{1}{2} \frac{D^2 k_F^2}{\rho_m v_l v_F} \frac{T}{T_{\text{BG}}}. \quad (26)$$

Equation (26) shows that l_{ep} decreases inverse linearly with increasing temperature and is proportional to $n^{-1/2}$. We note that $T_{\text{BG}} \sim k_F \sim \sqrt{n}$ has a carrier density dependence and increases with increased doping in the system.

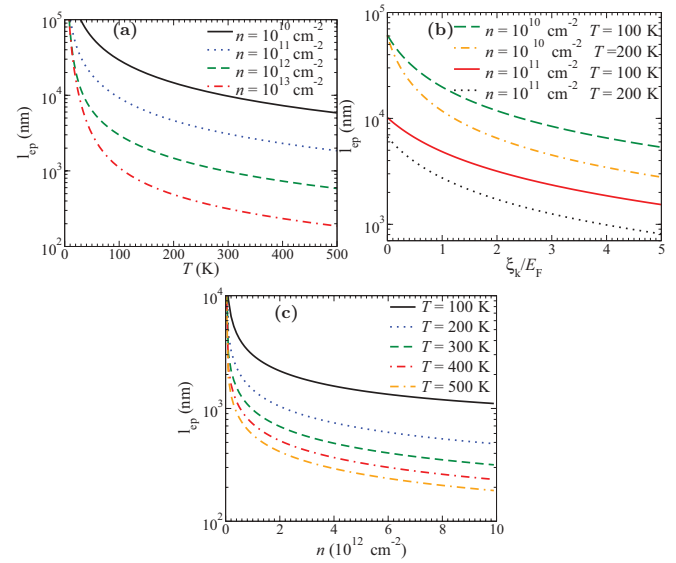


FIG. 8. (Color online) Calculated mean free path l_{ep} induced by e-p interaction. We use³⁷ $D = 25$ eV, $v_l = 2.6 \times 10^6$ cm/s, and $\rho_m = 7.6 \times 10^{-8}$ g/cm 2 . (a) l_{ep} for $\xi_k = \xi_{k_F}$ as a function of temperature T for different carrier densities. (b) l_{ep} as a function of energy ξ_k/E_F for different carrier densities and temperatures. (c) l_{ep} for $\xi_k = \xi_{k_F}$ as a function of carrier density for different temperatures.

C. Numerical results of l_{ep}

Figure 8 shows our numerical results for the mean free path l_{ep} . Figure 8(a) plots l_{ep} as a function of temperature for different values of carrier density. It is clear that l_{ep} decreases monotonically with increasing temperature. Figures 8(b) and 8(c) demonstrate that l_{ep} is a decreasing function of ξ_k and the carrier density n . From Fig. 8(c), we see that l_{ep} is longer than 1000 nm for $T < 100$ K and $n < 10^{13}$ cm $^{-2}$. Comparing Figs. 2(a) and 8(a), we find that l_{ep} is about one order of magnitude longer than the inelastic mean free path l induced by e-e interaction for $T < 100$ K and $n \lesssim 10^{12}$ cm $^{-2}$. Thus the inelastic scattering is dominated by e-e scattering processes in this regime. With increasing carrier density and temperature, l_{ep} becomes comparable to l , implying a considerable contribution of e-p interaction to the inelastic scattering processes. We mention that in the presence of both e-e and e-p interaction, the net quasiparticle scattering rate is given by $1/\tau_{\text{ee}} + 1/\tau_{\text{ep}}$, and thus the net inelastic mean free path goes as $\sim 1/(1/l_{\text{ee}} + 1/l_{\text{ep}})$.

V. DISCUSSION AND CONCLUSION

Before concluding, we first discuss the similarity and difference between graphene and conventional 2DES. Because of the gapless nature of graphene, there are two contributing bands in graphene, i.e., conduction and valence bands, which allow both interband and intraband single-particle excitations. By contrast, the conventional 2DES has only one contributing band, either the conduction or the valence band, because of the large energy gap. In addition, at zero temperature, $\text{Im}\Sigma_+^R(\mathbf{k}, \xi_k)$ of graphene is a smooth function of ξ_k , where both plasmon and interband excitations are absent. While there is a discontinuity

in $\text{Im}\Sigma^R(\mathbf{k}, \xi_{\mathbf{k}})$ for a 2DES caused by the plasmon²⁹ and electron-hole excitations,^{21,39} there is no such discontinuity in graphene due to its gaplessness.

We now discuss the difference between extrinsic and intrinsic graphene. The low-energy quasiparticle scattering rate of extrinsic graphene is quite similar to conventional 2DES, which is well described by the Fermi liquid theory. The nonmonotonic temperature dependence of $\text{Im}\Sigma_+^R(\mathbf{k}, \omega)$ in extrinsic graphene arises from the competition between plasmon broadening effects and thermally smeared single-particle excitation boundaries. On the other hand, the quasiparticle scattering rate of intrinsic graphene is linear in energy ω , a signature of the marginal Fermi liquid behavior. The characteristic feature of the nonmonotonic $\text{Im}\Sigma_+^R(\mathbf{k}, \omega)$ for intrinsic graphene as a function of temperature is due to an interplay between plasmon enhancement and enlarged single-particle excitation continua. We have also compared the inelastic mean free path with the elastic mean free path in order to assess the density and temperature ranges where the inelastic scattering length is decisively longer so that quantum interference is in principle allowed in graphene. When $l < l_e$, quantum interference induced localization effects cannot manifest itself. In addition, motivated by a recent experiment on double-layer graphene, we have obtained analytic results for inelastic scattering in double-layer graphene where one layer acts to screen the other layer.

Our numerical calculation shows that inelastic scattering due to e-p interaction is negligible for $T < 100$ K, and e-e interaction dominates in this temperature range. The e-p scattering starts to play a role in extrinsic graphene when the temperature is above 200 K. In particular, the temperature dependence of l_{ep} changes from T^{-2} to T^{-1} as the temperature increases from the low- T Bloch-Grüneisen regime to the high- T equipartition regime. On the other hand, the low-temperature asymptotic temperature dependence of the e-e interaction leads to $l \sim (T^2 \ln T)^{-1}$ for extrinsic graphene and $l \sim T^{-1}$ for intrinsic graphene.

We should note here that our calculation of the inelastic scattering length based on the imaginary part of the graphene self-energy is carried out in the so-called “ballistic limit” where disorder effects are neglected in the calculation of the inelastic mean free path itself. As such our calculated inelastic mean free path is an upper limit on the phase breaking length l_ϕ

applicable to graphene quantum interference phenomena. It is well known that disorder has qualitative and quantitative effects on the inelastic mean free path⁴⁰ and the phase breaking length, in general, suppressing the mean free path substantially from its ballistic limit. In the diffusive limit, we anticipate the inelastic mean free path due to e-e interaction to have the asymptotic low-temperature behavior of $l \sim (T \ln T)^{-1}$ instead of the $l \sim (T^2 \ln T)^{-1}$ ballistic behavior we find in Sec. II. The phase breaking length l_ϕ is anticipated to be $l_\phi \sim T^{-1}$ in the low-temperature diffusive regime. Thus the actual inelastic length due to e-e interaction would be smaller than the ballistic limit results we obtain in the current work. We note that the disorder effect on the electron-phonon interaction induced inelastic mean free path l_{ep} derived in Sec. IV is likely to be small,⁴⁰ and our ballistic limit results should apply equally well to the diffusive regime also.

To conclude, we have obtained analytical asymptotic behavior of $\text{Im}\Sigma_\pm^R(\mathbf{k}, \xi_{\mathbf{k}})$ in graphene utilizing the GW approximation. We have also analyzed $\text{Im}\Sigma_\pm^R(\mathbf{k}, \xi_{\mathbf{k}})$ for a double-layer graphene system. We have shown numerical results for the inelastic mean free path l and $\text{Im}\Sigma^R(\mathbf{k}, \omega)$. We emphasize that finite temperature has strong effects on the inelastic scattering mean free path. We have discussed the difference between graphene and conventional 2DES. We have also provided results for the inelastic mean free path arising from electron-phonon interaction, which becomes important only at very high temperatures since the typical e-p dimensionless coupling constant (< 0.04 for carrier density $n < 10^{13} \text{ cm}^{-2}$) is much less than the typical dimensionless coupling constant r_s (~ 0.4) in graphene. Our use of the GW approximation, which is the leading order Feynman-Dyson perturbative expansion in the dynamically screened Coulomb interaction, should be an excellent approximation for graphene (with quantitative predictive power) because of the small values of r_s (< 1) in graphene on substrates. Going beyond the GW approximation is a formidable task, which may not be necessary in understanding graphene inelastic processes.

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¹K. S. Novoselov, A. K. Geim, S. V. Morozov, D. Jiang, Y. Zhang, S. V. Dubonos, I. V. Grigorieva, and A. A. Firsov, *Science* **306**, 666 (2004); K. S. Novoselov, D. Jiang, F. Schedin, T. J. Booth, V. V. Khotkevich, S. V. Morozov, and A. K. Geim, *Proc. Natl. Acad. Sci. USA* **102**, 10451 (2005); K. S. Novoselov, A. K. Geim, S. V. Morozov, D. Jiang, M. I. Katsnelson, I. V. Grigorieva, S. V. Dubonos, and A. A. Firsov, *Nature (London)* **438**, 197 (2005).

²A. Bostwick, T. Ohta, T. Seyller, K. Horn, and E. Rotenberg, *Nat. Phys.* **3**, 36 (2007).

³S. Y. Zhou, D. A. Siegel, A. V. Fedorov, and A. Lanzara, *Phys. Rev. B* **78**, 193404 (2008).

⁴A. A. Kozikov, A. K. Savchenko, B. N. Narozhny, and A. V. Shytov, *Phys. Rev. B* **82**, 075424 (2010).

⁵D. C. Elias, R. V. Gorbachev, A. S. Mayorov, S. V. Morozov, A. A. Zhukov, P. Blake, L. A. Ponomarenko, I. V. Grigorieva, K. S. Novoselov, F. Guinea, and A. K. Geim, *Nat. Phys.* **7**, 701 (2011).

⁶S. Das Sarma, E. H. Hwang, and W.-K. Tse, *Phys. Rev. B* **75**, 121406 (2007).

⁷E. H. Hwang, B. Y.-K. Hu, and S. Das Sarma, *Physica E* **40**, 1653 (2008).

⁸M. Polini, R. Asgari, G. Borghi, Y. Barlas, T. Pereg-Barnea, and A. H. MacDonald, *Phys. Rev. B* **77**, 081411 (2008).

- ⁹M. Schütt, P. M. Ostrovsky, I. V. Gornyi, and A. D. Mirlin, *Phys. Rev. B* **83**, 155441 (2011).
- ¹⁰S. Das Sarma, S. Adam, E. H. Hwang, and E. Rossi, *Rev. Mod. Phys.* **83**, 407 (2011).
- ¹¹V. N. Kotov, B. Uchoa, V. M. Pereira, F. Guinea, and A. H. Castro Neto, *Rev. Mod. Phys.* **84**, 1067 (2012).
- ¹²B. L. Altshuler and A. G. Aronov, *Electron-Electron Interactions in Disordered Systems* (Elsevier, Amsterdam, 1985).
- ¹³W.-K. Tse, E. H. Hwang, and S. Das Sarma, *Appl. Phys. Lett.* **93**, 023128 (2008).
- ¹⁴D.-K. Ki, D. Jeong, J.-H. Choi, H.-J. Lee, and K.-S. Park, *Phys. Rev. B* **78**, 125409 (2008).
- ¹⁵F. V. Tikhonenko, D. W. Horsell, R. V. Gorbachev, and A. K. Savchenko, *Phys. Rev. Lett.* **100**, 056802 (2008).
- ¹⁶F. V. Tikhonenko, A. A. Kozikov, A. K. Savchenko, and R. V. Gorbachev, *Phys. Rev. Lett.* **103**, 226801 (2009).
- ¹⁷L. A. Ponomarenko, A. K. Geim, A. A. Zhukov, R. Jalil, S. V. Morozov, K. S. Novoselov, I. V. Grigorieva, E. H. Hill, V. V. Cheianov, V. I. Fal'ko, K. Watanabe, T. Taniguchi, and R. V. Gorbachev, *Nat. Phys.* **7**, 958 (2011).
- ¹⁸S. Das Sarma, E. H. Hwang, and Q. Li, *Phys. Rev. B* **85**, 195451 (2012).
- ¹⁹K. Kechedzhi, E. H. Hwang, and S. Das Sarma, *Phys. Rev. B* **86**, 165442 (2012).
- ²⁰J. González, F. Guinea, and M. A. H. Vozmediano, *Phys. Rev. Lett.* **77**, 3589 (1996).
- ²¹E. H. Hwang, B. Y.-K. Hu, and S. Das Sarma, *Phys. Rev. B* **76**, 115434 (2007).
- ²²T. Jungwirth and A. H. MacDonald, *Phys. Rev. B* **53**, 7403 (1996).
- ²³L. Zheng and S. Das Sarma, *Phys. Rev. B* **53**, 9964 (1996).
- ²⁴E. H. Hwang and S. Das Sarma, *Phys. Rev. B* **75**, 205418 (2007).
- ²⁵M. R. Ramezani, M. M. Vazifeh, R. Asgari, M. Polini, and A. H. MacDonald, *J. Phys. A* **42**, 214015 (2009).
- ²⁶E. H. Hwang, R. Sensarma, and S. Das Sarma, *Phys. Rev. B* **84**, 245441 (2011).
- ²⁷Y. Zhang and S. Das Sarma, *Phys. Rev. B* **71**, 045322 (2005).
- ²⁸J. J. Quinn and R. A. Ferrell, *Phys. Rev.* **112**, 812 (1958).
- ²⁹G. F. Giuliani and J. J. Quinn, *Phys. Rev. B* **26**, 4421 (1982).
- ³⁰L. Zheng and S. Das Sarma, *Phys. Rev. B* **54**, 13908 (1996).
- ³¹L. Zheng and A. H. MacDonald, *Phys. Rev. B* **49**, 5522 (1994).
- ³²R. E. V. Profumo, M. Polini, R. Asgari, R. Fazio, and A. H. MacDonald, *Phys. Rev. B* **82**, 085443 (2010).
- ³³E. H. Hwang and S. Das Sarma, *Phys. Rev. B* **77**, 081412 (2008).
- ³⁴Q. Li, E. H. Hwang, and S. Das Sarma, *Phys. Rev. B* **84**, 115442 (2011).
- ³⁵G. D. Mahan, *Many-Particle Physics*, 3rd ed. (Kluwer Academic/Plenum, New York, 2000).
- ³⁶E. H. Hwang and S. Das Sarma, *Phys. Rev. B* **77**, 115449 (2008).
- ³⁷H. Min, E. H. Hwang, and S. Das Sarma, *Phys. Rev. B* **83**, 161404 (2011).
- ³⁸K. Kaasbjerg, K. S. Thygesen, and K. W. Jacobsen, *Phys. Rev. B* **85**, 165440 (2012).
- ³⁹R. Jalabert and S. Das Sarma, *Phys. Rev. B* **40**, 9723 (1989).
- ⁴⁰D. Belitz and S. Das Sarma, *Phys. Rev. B* **36**, 7701 (1987), and references therein.